Notice of References Cited Application/Control No. 10/720,672 Examiner Tuyen To Applicant(s)/Patent Under Reexamination NOVAKOVSKY ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,438,734	08-2002	Lu, Dingqing	716/7
	В	US-6,745,160	06-2004	Ashar et al.	703/14
	С	US-6,711,534	03-2004	Parashkevov, Atanas Nikolaev	703/15
	D	US-			
	Е	US-			_
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Novakovsky, S.; Shyman, S.; Hanna, Z.; "High capacity and automatic functional extraction tool for industrial VLSI circuit designs"; Computer Aided Design, 2002. ICCAD 2002. IEEE/ACM International Conference on 10-14 Nov. 2002 Page(s): 520 - 525
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.